

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WEIMER ET AL.	
		Examiner Tae H. Yoon	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,235,270	05-2001	Ishii et al.	424/59
*	B	US-6,899,948	05-2005	Zhang et al.	428/331
*	C	US-6,913,827	07-2005	George et al.	428/402
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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